

VDS	RDS(on)	ID@25℃
1700V	1000mΩ	5A

Applications:

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- EV Charging
- Motor Drives

Features:

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness

Benefits:

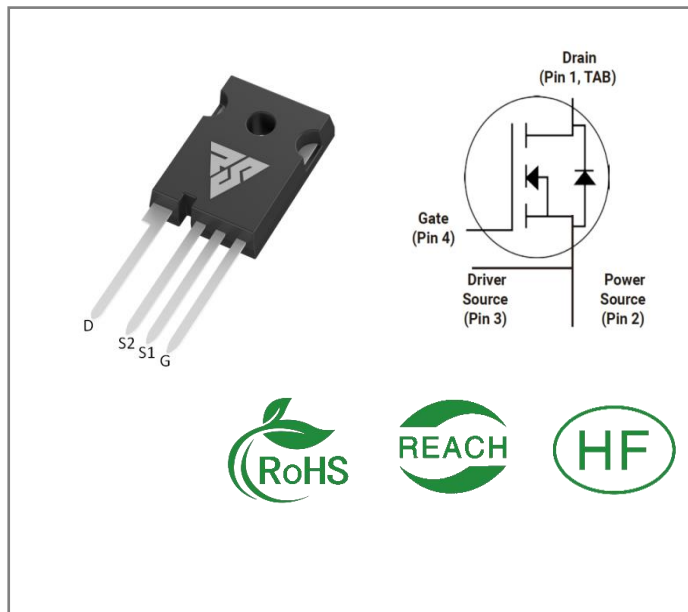
- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RSM1701K0Z	TO-247-4	RSM1701K0Z	Tube	30 PCS

Maximum Ratings (TJ= 25℃ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
VDSmax	Drain - Source Voltage	1700	V	VGS=0V, ID =100μA	
VGSmax	Gate - Source Voltage	-10/+2 5	V	Absolute maximum values	
VGSop	Gate - Source Voltage	-5/+20	V	Recommended operational values	
ID	Continuous Drain Current	5 3.5	A	VGS=20V, TC =25℃ VGS=20V, TC =100℃	
ID(pulse)	Pulsed Drain Current	6	A	Pulse width tp limited by TJmax	
PD	Power Dissipation	69	W	TC =25℃, TJ =150℃	
TL	Solder Temperature	260	℃		
TJ, Tstg	Operating Junction and Storage Temperature	-55 to + 150	℃		



Electrical Characteristics (TJ= 25°C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V(BR)DSS	Drain-Source Breakdown Voltage	1700			V	VGS=0V, ID =100μA	
VGS(th)	Gate Threshold Voltage	2.5	3.0	4.5	V	VGS= VDS, IDS=1mA, TC =25°C	
			2.2		V	VGS= VDS, IDS=1mA, TC =150°C	
IDSS	Zero Gate Voltage Drain Current		1	100	μA	VDS= 1700V, VGS=0V	
IGSS	Gate-Source Leakage Current			250	nA	VGS=25V, VDS= 0V	
RDS(on)	Drain-Source on-state Resistance		1000	1300	mΩ	VGS=20V, ID =2A, TC =25°C	
			1500			VGS=20V, ID =2A, TC =150°C	
Ciss	Input Capacitance		186		pF	VGS=0V, VDS=1000 V, f=1MHz, VAC=25 mV	
Coss	Output Capacitance		12				
Crss	Reverse Transfer Capacitance		1.6				
EON	Turn-On Switching Energy		48		μJ	VDS =1200V, VGS =-5/20V, ID = 2A, RG(ext) = 2.5Ω, L= 1500μH	
EOFF	Turn-Off Energy		18				
td(on)	Turn-On Delay Time		5.2		ns	VDS =1200V, VGS =-5/20 V ID = 2A, RG(ext) =2. 5 Ω , RL =600Ω	
tr	Rise Time		9.4				
td(off)	Turn-Off Delay Time		13.2				
tf	Fall Time		22				
RG(int)	Internal Gate Resistance		22		Ω	f=1 MHz, VAC=25mV	
Qgs	Gate to Source Charge		5.2		nC	VDS=1200V, VGS=-5/20V ID =2A	
Qgd	Gate to Drain Charge		7.3		nC		
Qg	Total Gate Charge		21.8				

Reverse Diode Characteristics (T_J= 25°C unless otherwise specified)

Symbol	Parameter	Typ.	Max	Unit	Test Conditions	Note
VSD	Diode Forward Voltage	4.2		V	V _{GS} =-5V, I _{SD} = 1 A, T _J = 25°C	
		3.9		V	V _{GS} =-5V, I _{SD} = 1 A, T _J = 150°C	
I _S	Continuous Diode Forward Current		4	A	V _{GS} =-5V, T _C = 25°C	
t _{rr}	Reverse Recovery time	25		ns	I _{SD} = 2 A, V _R = 1200V	
Q _{rr}	Reverse Recovery Charge	15		nC		
I _{rrm}	Peak Reverse Recovery Current	2.8		A		

Thermal Characteristics (T_J= 25°C unless otherwise specified)

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
R _{θJC}	Thermal Resistance from Junction to Case	1.8	°C/W		
R _{θJA}	Thermal Resistance From Junction to Ambient	40			

Typical Feature Curve

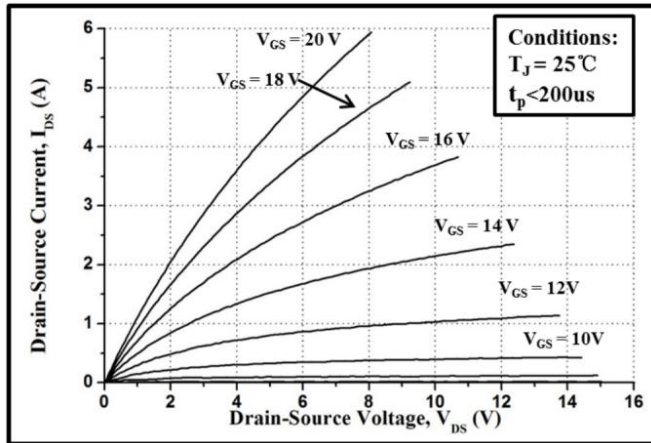


Figure 1. Typical Output Characteristics $T_J = 25^\circ\text{C}$

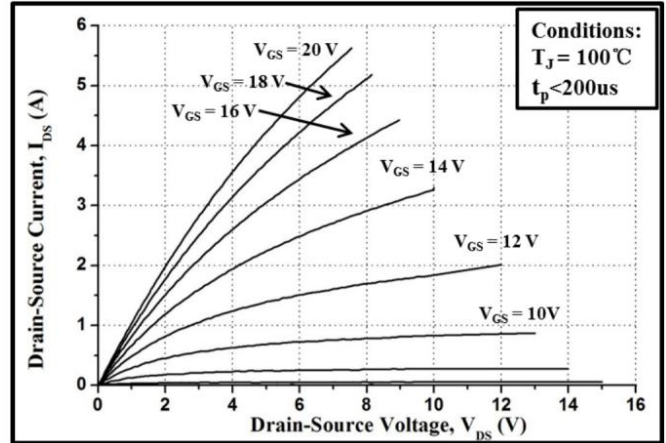


Figure 2. Typical Output Characteristics $T_J = 100^\circ\text{C}$

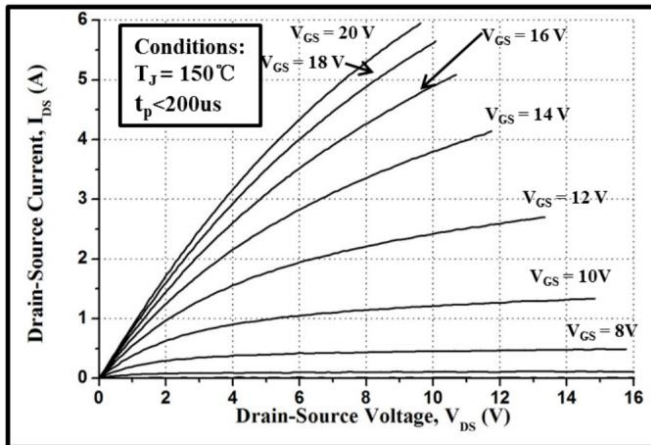


Figure 3. Typical Output Characteristics $T_J = 150^\circ\text{C}$

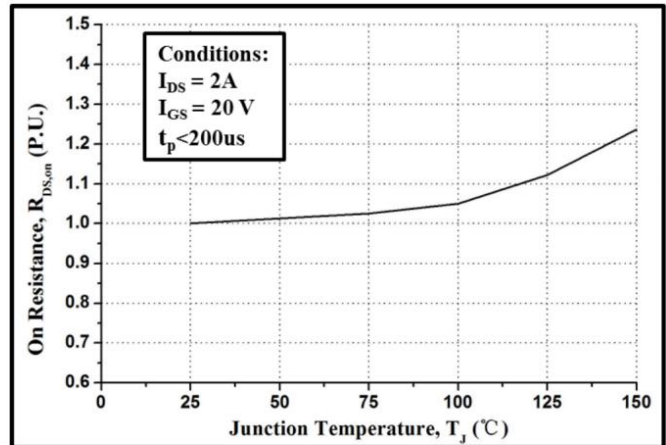


Figure 4. Normalized On-Resistance vs. Temperature

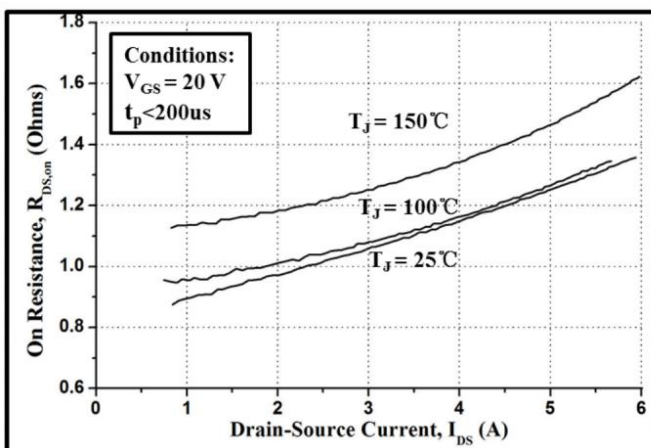


Figure 5. On-Resistance vs. Drain Current

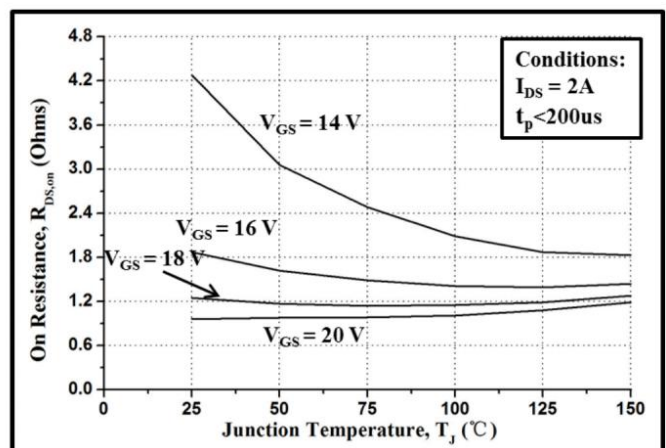


Figure 6. On-Resistance vs. Temperature

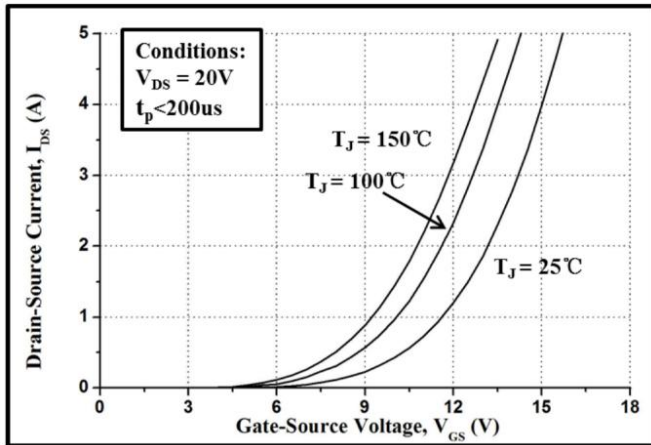


Figure 7. Typical Transfer Characteristics

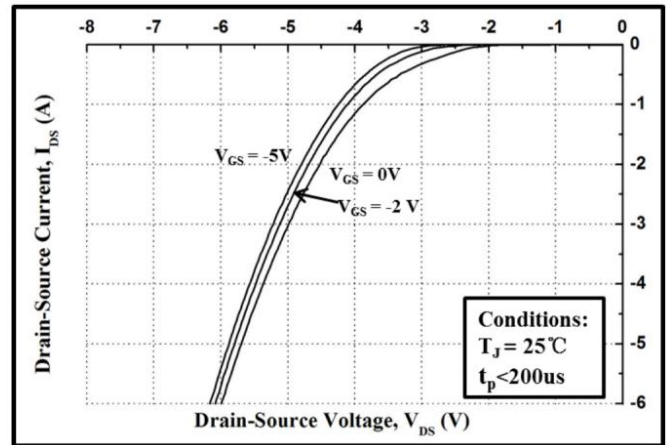


Figure 8. Body Diode Characteristics at 25°C

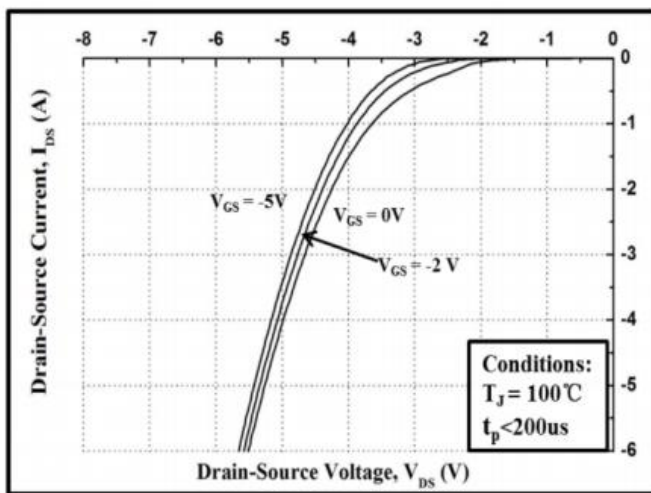


Figure 9. Body Diode Characteristics at 100°C

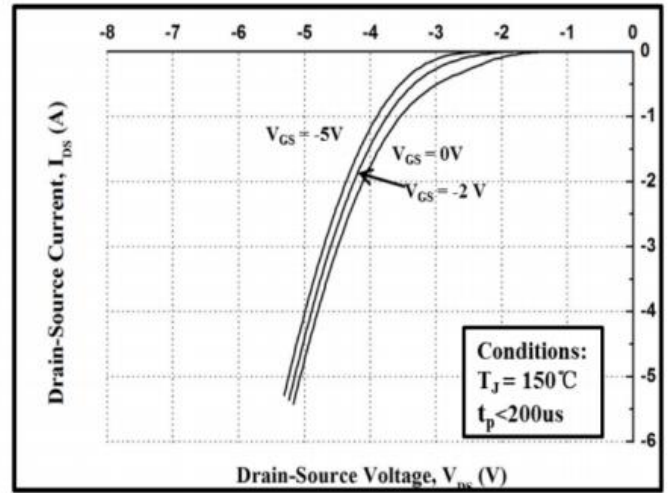


Figure 10. Body Diode Characteristics at 150°C

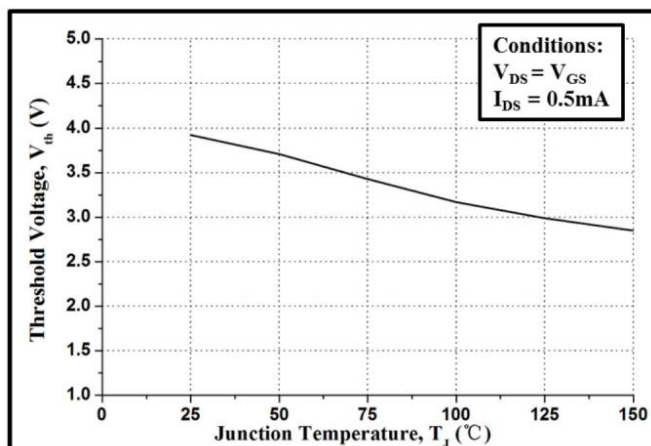


Figure 11. Gate Threshold Voltage vs. Temperature

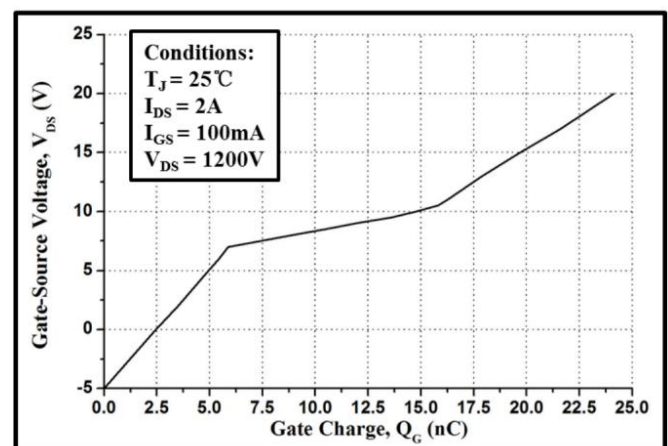


Figure 12. Gate Charge Characteristic

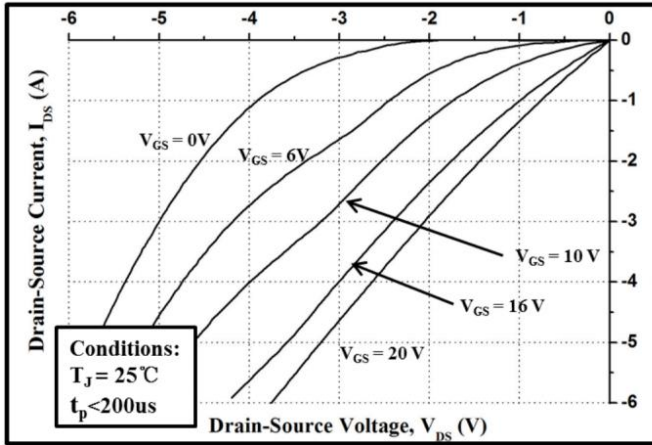


Figure 13. 3rd Quadrant Characteristics at 25°C

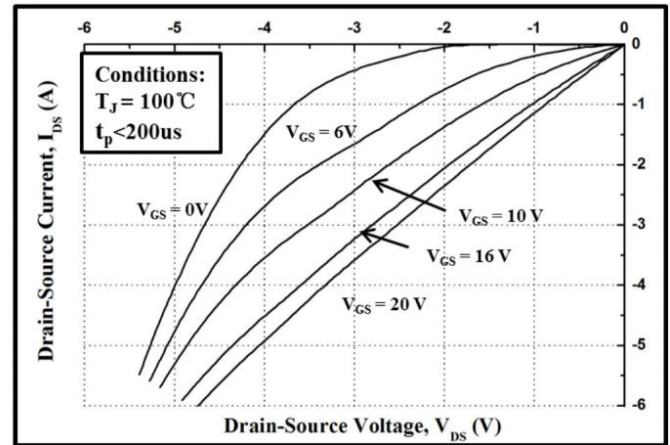


Figure 14. 3rd Quadrant Characteristics at 100°C

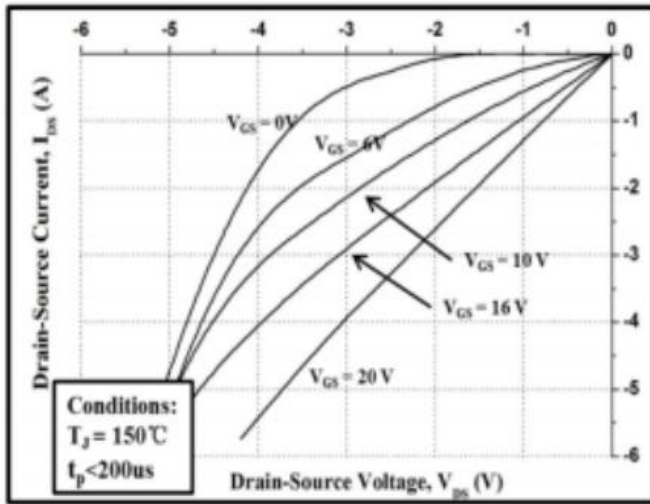


Figure 15. 3rd Quadrant Characteristics at 150°C

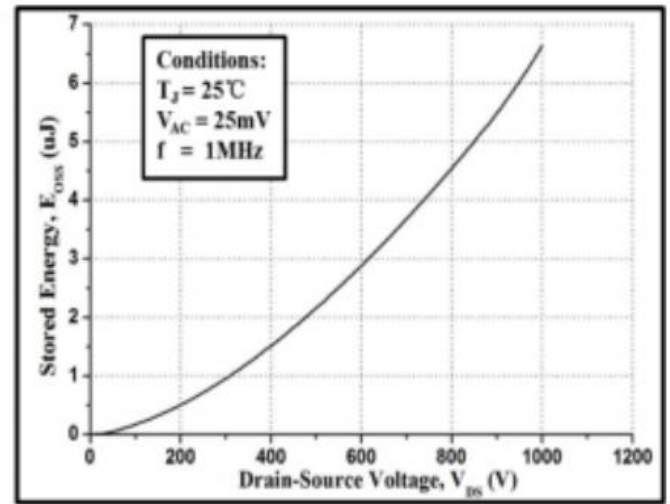


Figure 16. Output Capacitor Stored Energy

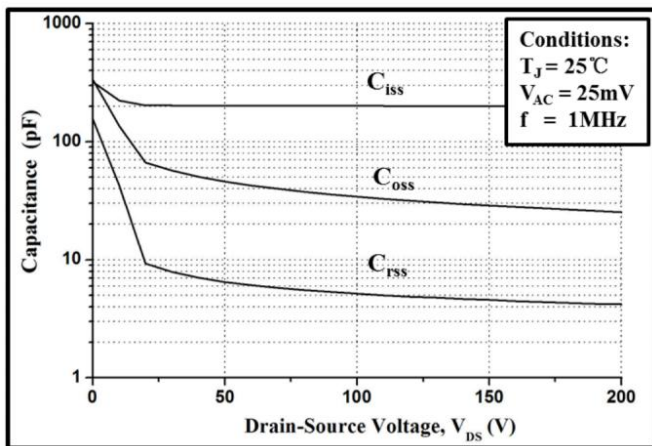


Figure 17. Capacitances vs. Drain-Source Voltage

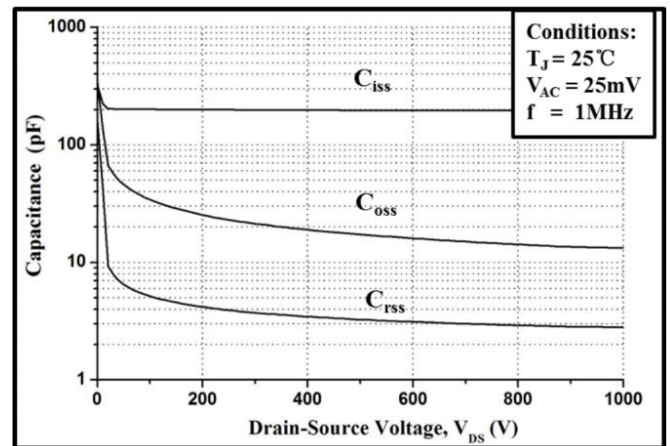
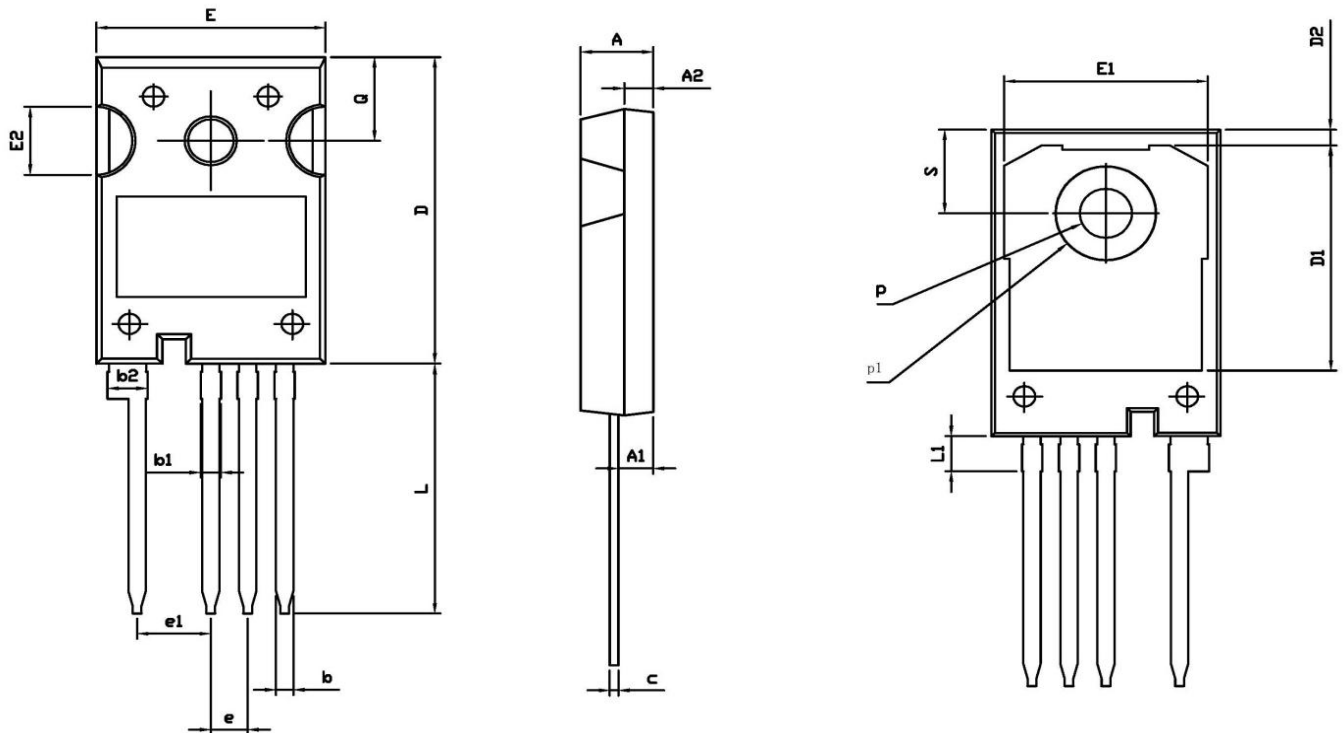
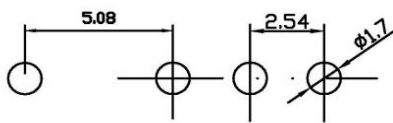


Figure 18. Capacitances vs. Drain-Source Voltage

Package outline drawing(TO-247-4 Unit: mm)

RECOMMENDED LAND PATTERN


UNIT: mm

	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.25	2.40	2.45
A2	1.85	2.00	2.15
b	1.05	1.20	1.35
b1	1.00	1.30	1.60
b2	2.35	2.65	2.95
c	0.50	0.60	0.70
D	22.34	22.54	22.74
D1	16.00	16.50	17.00
D2	0.97	1.17	1.37
e	2.34	2.54	2.74
e1	4.88	5.08	5.28
E	15.60	15.80	16.00
E1	13.50	14.00	14.50
E2	4.80	5.00	5.20
L	18.08	18.38	18.68
L1	2.38	2.58	2.78
p	3.50	3.60	3.70
p1	6.60	6.80	7.00
Q	6.00	6.15	6.30
S	6.00	6.15	6.30

Disclaimers:

Reasunos Semiconductor Technology Co.Ltd (Reasunos) reserves the right to make changes without notice in order to improve reliability,function or design and to discontinue any product or service without notice .Customers should obtain the latest relevant information before orders and should verify that such information in current and complete.All products are sold subject to Reasunos's terms and conditions supplied at the time of orderacknowledgement.

Reasunos Semiconductor Technology Co.Ltd warrants performance of its hardware products to the specifications at the time of sale.Testing,reliability and quality control are used to the extene Reasunos deems necessary to support this warrantee. Except where agreed upon by contr- actual agreement,testing of all parameters of each product is not necessarily performed.

Reasunos Semiconductor Technology Co.Ltd does not assume any liability arising from the use of any product or circuit designs described herein.Customers are responsible for their products and applications using Reasunos's components.To minimize risk,customers must provide adequate design and operating safeguards.

Reasunos Semiconductor Technology Co.Ltd does not warrant or convey any license either expressed or implied under its patent rights,nor the rights of others.Reproduction of information in Reasunos's data sheets or data books is permissible only if reproduction is without modification oralteration.Reproduction of this information with any alteration is an unfair and deceptive business practice. Reasunos Semiconductor Technology Co.Ltd is not responsible or liable for such altered documentation.

Resale of Reasunos's products with statements different from or beyond the parameters stated by Reasunos Semiconductor Technology Co.Ltd for that product or service voids all expressed or implied warranties for the associated Reasunos's product or service and is unfair and deceptive business practice. Reasunos Semiconductor Technology Co.Ltd is not responsible or liable for such statements.

Life Support Policy:

Reasunos Semiconductor Technology Co.Ltd's Products are not authorized for use as critical components in life support devices or systems without the expressed written approval of Reasunos Semiconductor Technology Co.Ltd.

As used herein:

1. Life support devices or systems are devices or systems which: a.are intended for surgical implant into the human body, b.support or sustain life, c.whose failuer to when properly used in accordance with instructions for used provided in the laeling,can be reasonably expected to result in significant injury to the user.

2.A critical component is any component of a life support device or system whose failure to system whose failure to perform can be reasonably expected to cause the failure of the life support device or system,or to affect its safety or effectiveness.